

SEMICONDUCTOR



# **P-Channel Switch**

- This device is designed for low level analog switching sample and hold circuits and chopper stabilized amplifiers.
- Sourced from process 88.



# Absolute Maximum Ratings T<sub>C</sub>=25°C unless otherwise noted

Symbol	Parameter	Value	Units	
V <sub>DG</sub>	Drain-Gate Voltage	- 30	V	
V <sub>GS</sub>	Gate-Source Voltage	30	V	
I <sub>GF</sub>	Forward Gate Current	50	mA	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range	-55 ~ +150	°C	

#### NOTES:

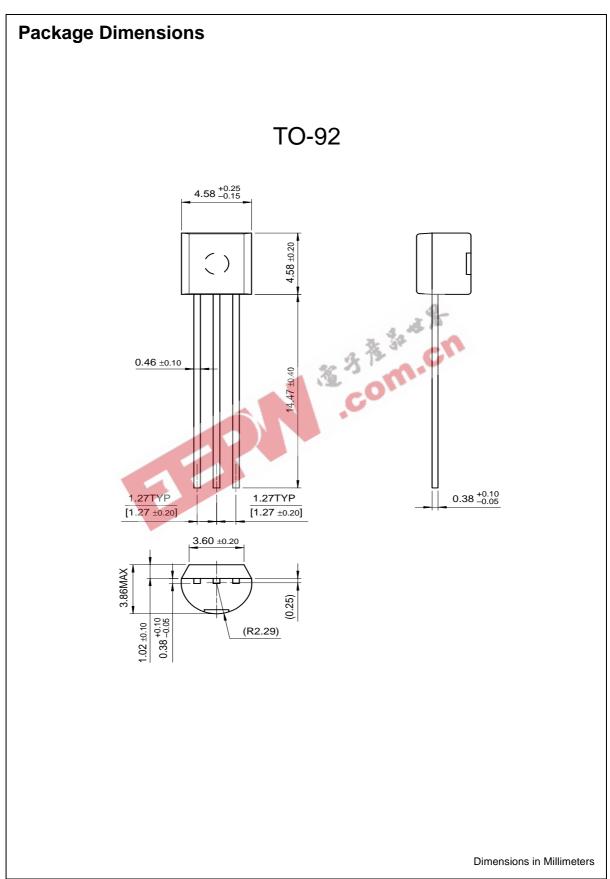
These ratings are based on a maximum junction temperature of 150 degrees C.
 These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

## Electrical Characteristics T<sub>C</sub>=25°C unless otherwise noted

Symbol	Parameter	Test Condition		Min.	Тур.	Max.	Units
BV <sub>GSS</sub>	Gate-Source Breakdown Voltage	$V_{DS} = 0V, IG = 1\mu A$		30			V
I <sub>GSS</sub>	Gate Reverse Current	V <sub>GS</sub> = 15V	V <sub>GS</sub> = 15V			2	nA
I <sub>D</sub> (off)	Drain Cutoff Leakage Current	V <sub>DS</sub> = 15V				10	nA
		$V_{GS} = 7V$	T = +85°C			0.5	μΑ
I <sub>DGO</sub>	Drain-Gate Leakage Current	V <sub>DG</sub> = 15V				2	NA
		I <sub>S</sub> = 0	T = +85°C			0.1	μΑ
I <sub>DSS</sub>	Zero-Gate Voltage Drain Current	$V_{DS} = 20V, V_{C}$	$V_{DS} = 20V, V_{GS} = 0V$				mA
V <sub>GS</sub> (off)	Gate-Source Cutoff Voltage	$V_{DS} = 15V, I_D = 1\mu A$				5	V
V <sub>DS</sub> (on)	Drain-Source On Voltage	$V_{GS} = 0V, I_D = 3mA$				0.5	V
r <sub>DS</sub> (on)	Drain-Source On Resistance	$V_{GS} = 0V, I_D = 1mA$				150	Ω
r <sub>ds</sub> (on)	Drain-Source On Resistance	$V_{GS} = 0V, I_D = 0, f = 1kHz$				150	Ω
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 15V, V <sub>GS</sub> = 0V, f = 1MHz				45	рF
C <sub>rss</sub>	Reverse Transfer Capacitance	$V_{DS} = 0V, V_{GS} = 7V, f = 1MHz$				10	pF
t <sub>d</sub> (on)	Trun On Time	$V_{DD} = -6V$ $V_{GS}(off) = +7V$ $R_{L} = 1.8k\Omega$ $I_{D}(on) = -3MA$				15	ns
t <sub>r</sub>	Rise Time					75	ns
t <sub>d</sub> (off)	Trun Off Time					25	ns
t <sub>f</sub>	Fall Time					100	ns

# Thermal Characteristics $T_A=25$ °C unless otherwise noted

Symbol	Parameter	Max.	Units	
P <sub>D</sub>	Total Device Dissipation	350	mW	
	Derate above 25°C	2.8	mW/°C	
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction to Case	125	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	357	°C/W	



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